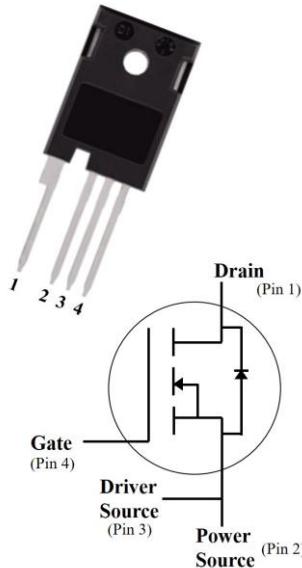


**Silicon Carbide Power MOSFET (N-Channel Enhancement)**

V <sub>DS</sub>	1200V
I <sub>D (25°C)</sub>	167A
R <sub>DS(on)</sub>	13mΩ

**Features**

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant

**Typical Applications**

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

**Mechanical Data**

- **Package:** TO247-4L
- **Terminals:** Tin plated leads
- **Polarity:** As marked

**■Maximum Ratings (T<sub>C</sub>=25°C Unless otherwise specified)**

D212014NCFG1

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D212013NCFG1	
Drain source voltage @ T <sub>j</sub> =25°C	V <sub>DS,max</sub>	V	1200	V <sub>GS</sub> =0 V, I <sub>D</sub> =100uA	
Gate source voltage @ T <sub>j</sub> =25°C	V <sub>GS,max</sub>	V	-10/+22	Absolute maximum values (AC f > 1Hz, duty cycle < 1%)	
Gate source voltage @ T <sub>j</sub> =25°C	V <sub>GS,op</sub>	V	-5/+18	Recommended operational values	
Continuous drain current @ T <sub>c</sub> =25°C	I <sub>D</sub>	A	167	V <sub>GS</sub> =18V, T <sub>c</sub> =25°C	Fig.14
Continuous drain current @ T <sub>c</sub> =100°C			118	V <sub>GS</sub> =18V, T <sub>c</sub> =100°C	
Pulsed drain current	I <sub>D(pulsed)</sub>	A	334	Pulse width t <sub>p</sub> limited by T <sub>j,max</sub>	Fig.3
Power Dissipation	P <sub>TOT</sub>	W	555	T <sub>c</sub> =25°C , T <sub>j</sub> = 175°C	Fig.13
Operating junction and Storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	°C	-55 to +175		
Soldering temperature	T <sub>L</sub>	°C	260	1.6mm (0.063") from case for 10s	
Mounting torque	T <sub>M</sub>	Nm	1.0	M3 screw Maximum of mounting process: 3	


**■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	V <sub>GS(th)</sub>	V	2.0	2.9	4.0	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 20mA	Fig.11
Drain source breakdown voltage	V <sub>(BR)DSS</sub>	V	1200			V <sub>GS</sub> =0, I <sub>D</sub> =100uA	
Zero gate voltage drain current	I <sub>DSS</sub>	uA		1	100	V <sub>DS</sub> =1200V, V <sub>GS</sub> = 0V	
Gate source leakage current	I <sub>GSS</sub>	nA		1	100	V <sub>GS</sub> = 18V, V <sub>DS</sub> =0V	
Current drain source on-state resistance	R <sub>DS ON</sub>	mΩ		13	17	V <sub>GS</sub> =18V, I <sub>D</sub> =70A	Fig.4, 6, 7
				20		V <sub>GS</sub> =18V, I <sub>D</sub> =70A, T <sub>J</sub> =175°C	
Transconductance	g <sub>f</sub>	S		48		V <sub>DS</sub> =20V, I <sub>D</sub> =70A, T <sub>J</sub> =25°C	Fig.5

**■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C <sub>iss</sub>	pF		3815		V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C, f=100K Hz, V <sub>AC</sub> = 25mV	Fig.10
Output capacitance	C <sub>oss</sub>			239			
Reverse capacitance	C <sub>rss</sub>			29			
C <sub>oss</sub> stored energy	E <sub>oss</sub>	uJ		311		V <sub>DS</sub> =800V, V <sub>GS</sub> =-5/18V, I <sub>D</sub> =70A	Fig.12
Gate source charge	Q <sub>gs</sub>	nC		46			
Gate drain charge	Q <sub>gd</sub>			100			
Gate charge	Q <sub>g</sub>			216			
Internal Gate Resistance	R <sub>G(int)</sub>	Ω		5.2		f =1MHz, V <sub>AC</sub> = 25mV	

**■ Switching Characteristics (Tc=25°C unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on switching energy	t <sub>d(on)</sub>	ns		15		V <sub>DD</sub> =800V, V <sub>GS</sub> =-5/+18V, I <sub>D</sub> =70A, L=150 uH, R <sub>G(ext)</sub> = 2.5Ω	Fig.16
Turn off switching energy	t <sub>r</sub>			70			
Turn on delay time	t <sub>d(off)</sub>			82			
Rise time	t <sub>f</sub>			27			
Turn off delay time	E <sub>on</sub>	uJ		2483		Fig.17, 18	
Fall time	E <sub>off</sub>			1669			

**■Body diode characteristics (T<sub>c</sub>=25°C unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	V <sub>SD</sub>	V		4.7		V <sub>GS</sub> =-5V, I <sub>SD</sub> =37.5A	Fig.8
Continuous diode forward current	I <sub>s</sub>	A		104		V <sub>GS</sub> =-5V, T <sub>c</sub> =25°C	Fig.9
Reverse recovery time	t <sub>rr</sub>	nS		75		V <sub>DS</sub> =800V, V <sub>GS</sub> =-5V, I <sub>SD</sub> =70A, RG(ext)=2.5Ω, T <sub>j</sub> = 175°C	
Reverse recovery charge	Q <sub>rr</sub>	nC		2080			
Peak reverse recovery current	I <sub>rrm</sub>	A		45			

**■Thermal Characteristics (T<sub>a</sub>=25°C Unless otherwise specified)**

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	R <sub>θJ-C</sub>	°C /W	0.27

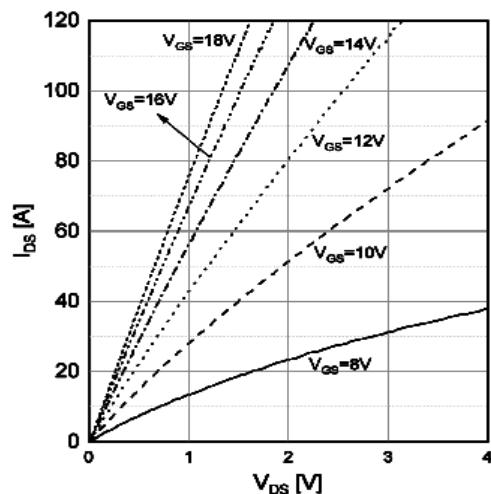
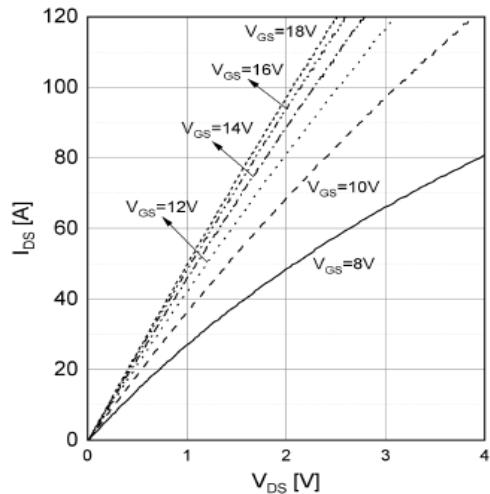
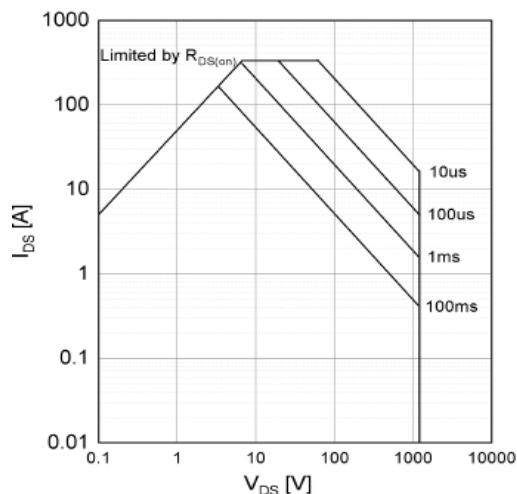
**■Typical Characteristics**

 Figure 1. Output Characteristics T<sub>j</sub> =25°C

 Figure2. Output Characteristics T<sub>j</sub> = 175 °C


Figure 3. Safe Operating Area

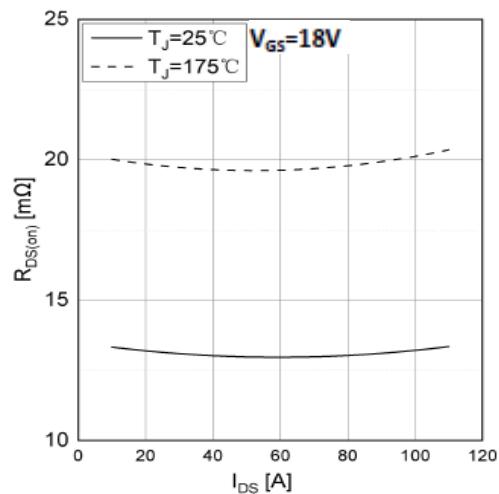


Figure 4. On-resistance vs. drain current

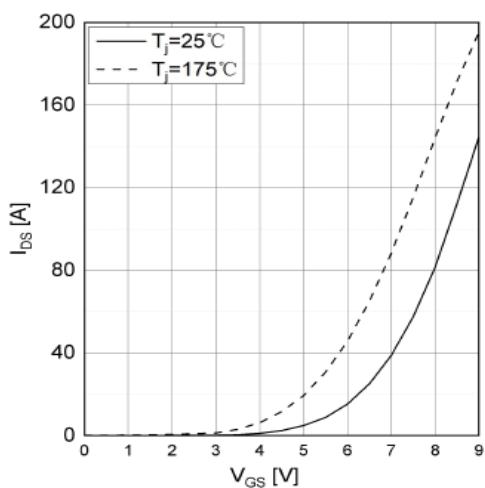


Figure 5. Transfer Characteristics for various  $T_j$

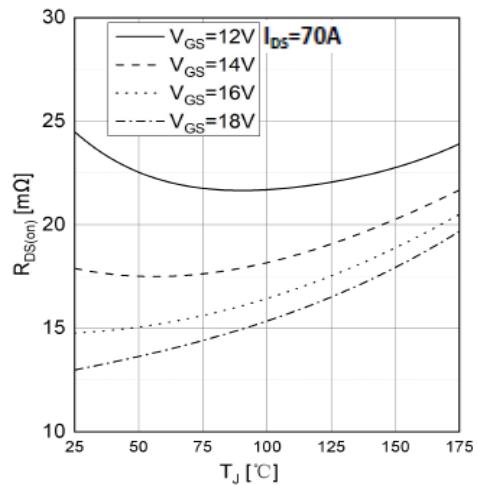


Figure 6. On-resistance vs. Temperature for various Gate voltage

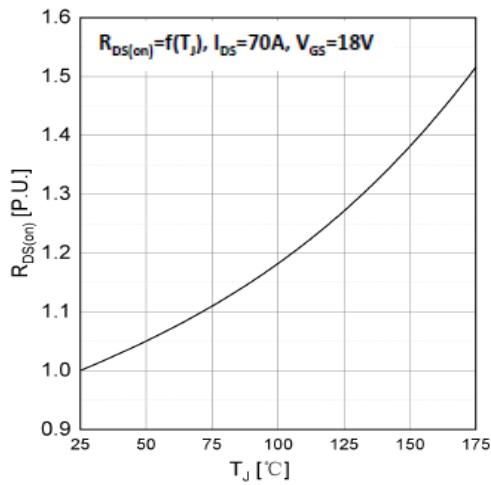


Figure 7. Normalized On-Resistance vs. Temperature

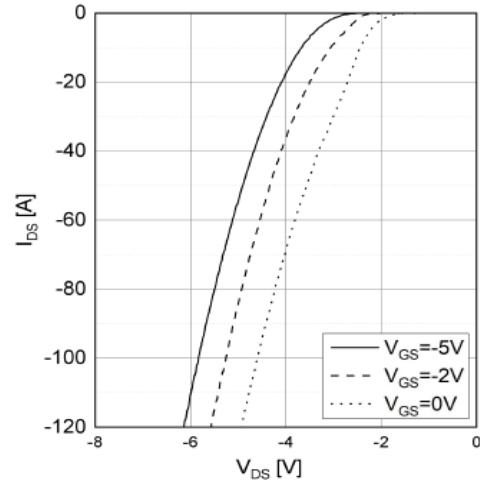


Figure 8. Reverse Output Characteristics at  $T_j = 25^\circ\text{C}$

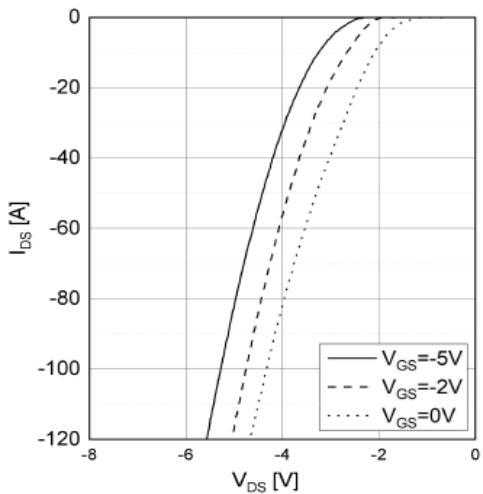


Figure 9. Reverse Output Characteristics at  $T_j = 175^\circ\text{C}$

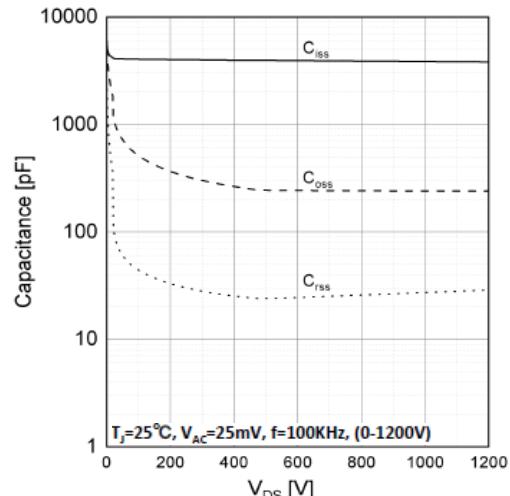
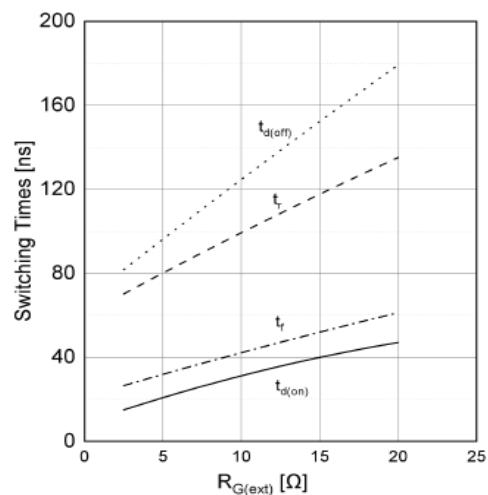
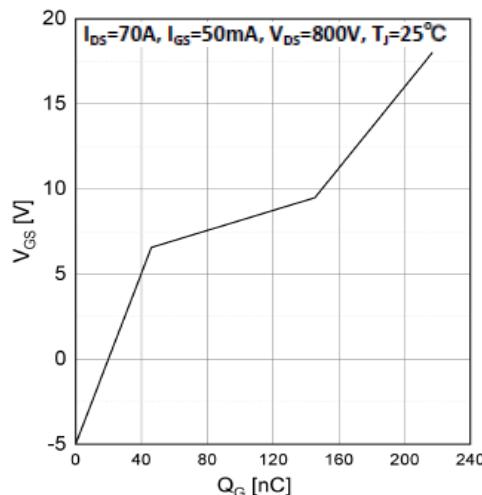
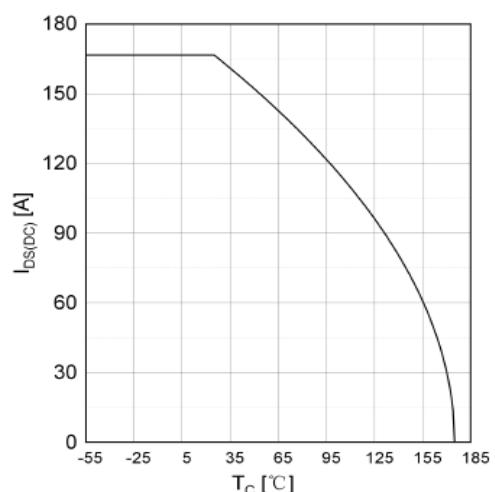
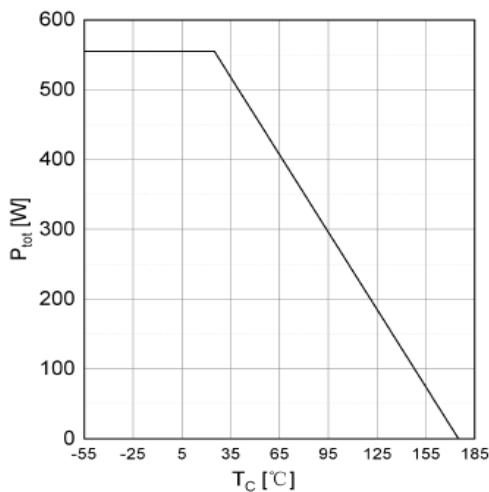
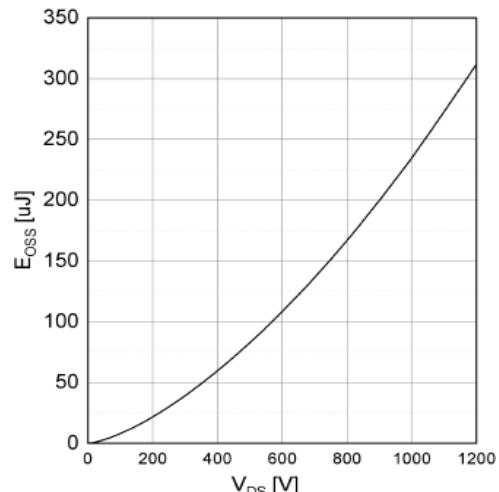
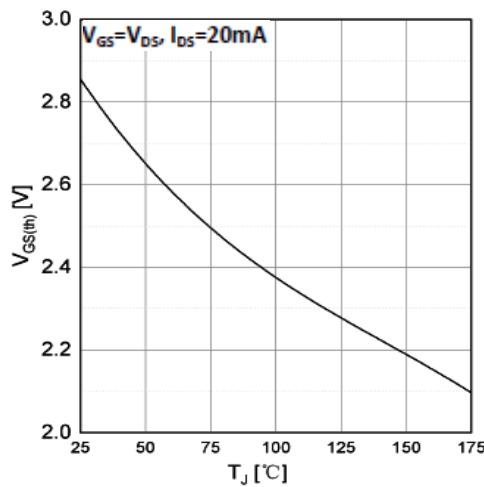


Figure 10. Capacitances vs. Drain to Source Voltage



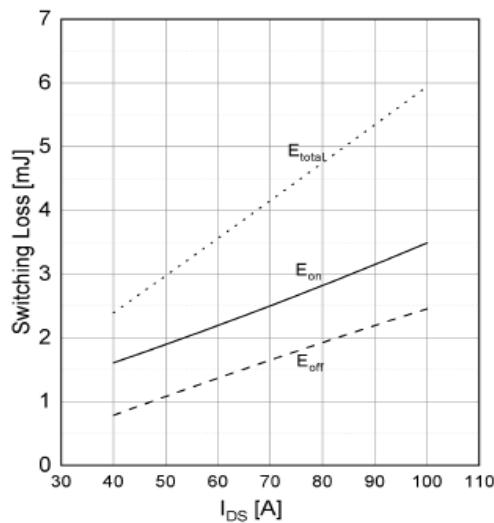


Figure 17. Clamped Inductive Switching Energy vs. Drain Current

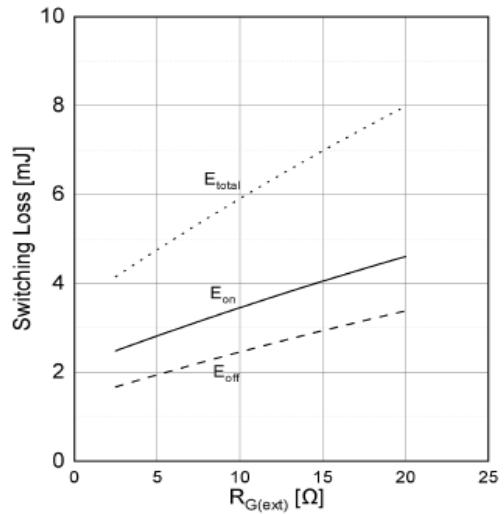
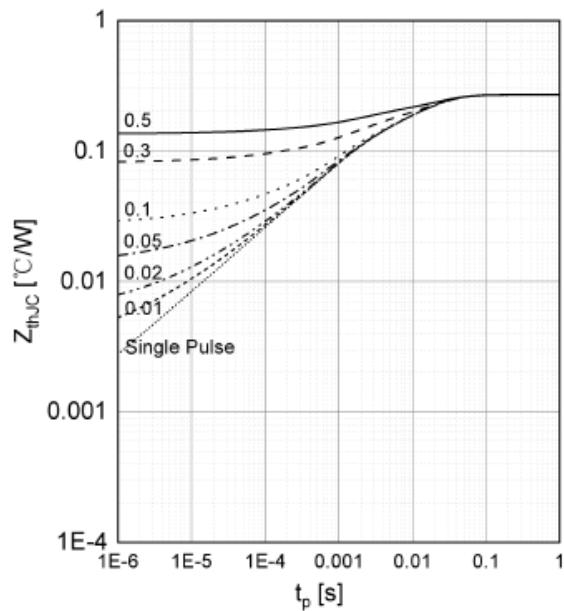
Figure 18. Clamped Inductive Switching Energy vs. External Gate Resistor (R<sub>G(ext.)</sub>)

Figure 19. Transient Junction to Case Thermal Impedance

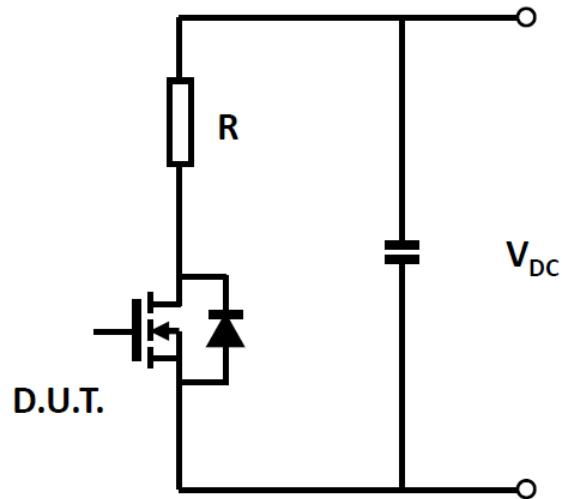


Figure 20. Schematic of Resistive Switching

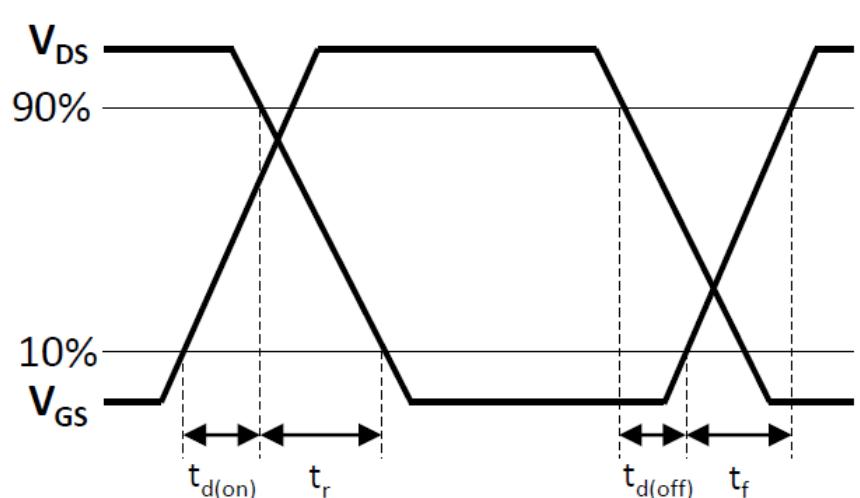
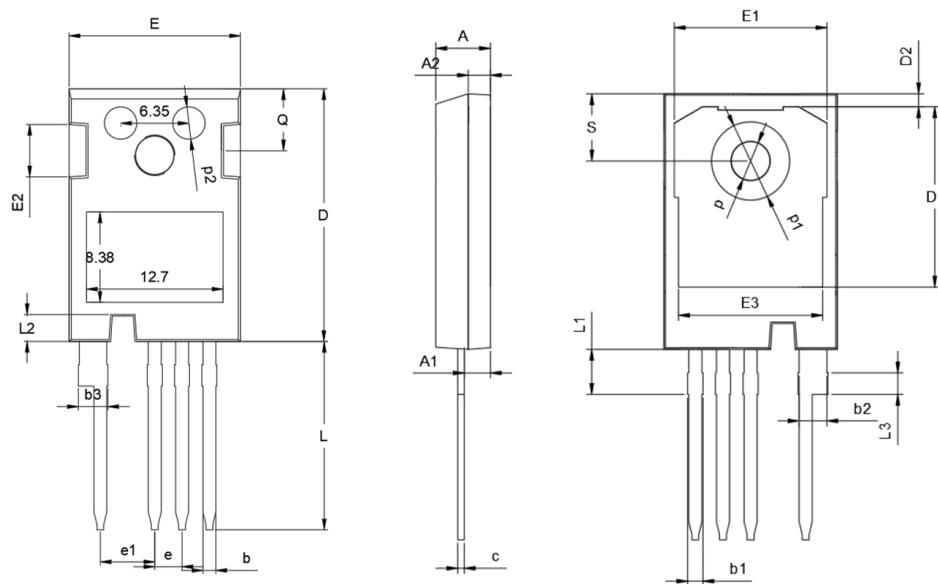


Figure 21. Switching Times Definition

## ■Outline Dimensions



TO247-4L			
Dim	Min	Norm	Max
A	4.80	5.00	5.20
A1	2.30	2.40	2.50
A2	1.88	1.98	2.08
b	1.10	1.20	1.30
b1	1.20	/	1.50
b2	2.35	2.55	2.75
b3	2.45	/	2.85
c	0.55	0.60	0.65
D	23.3	23.45	23.6
D1	16.25	16.55	16.85
D2	1.00	/	1.30
e	TYP2.54		
e1	TYP5.06		
E	15.75	15.90	16.05
E1	13.80	/	14.20
E2	4.40	4.75	5.10
E3	13.00	/	13.45
L	17.34	17.49	17.64
L1	4.00	/	4.30
L2	2.35	/	2.65
L3	TYP1.98		
Q	5.60	5.80	6.00
S	6.05	/	6.30
p	TYP3.58		
p1	TYP7.18		
p2	TYP3.00		



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